

Notice of References Cited		Application/Control No. 10/567,260	Applicant(s)/Patent Under Reexamination KRAUS ET AL.	
		Examiner LING-SIU CHOI	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,117,921	09-2000	Ma et al.	523/161
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP 1 184 353 A1	03-2002	Europe	Amaya et al.	---
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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